Search	earch Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/678,186	BAUTISTA ET AL.	
Examiner	Art Unit `	
Mark J. Beauchaine	3653	

	SEAR	CHED	
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221	133,3,9, 13,129	7/6/2005	МЈВ
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST 2.0.1.4 - USPAT, USPGPUB, JPO, EPO, DERWENT	7/6/2005	МЈВ
Primary Examiner; Class 221 - Ken Noland		
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